

**Notice of References Cited**

 Application/Control No.  
 09/851,991

 Applicant(s)/Patent Under Reexam  
 Hiraguchi et al.

Examiner

Craig A. Renner

Art Unit

2652

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification<sup>2</sup></b>	
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<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.

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